

SPECORD PLUS Series UV/Vis Spectrophotometer



Technical Data

SPECORD PLUS Series

General

- UV/Vis Spectrophotometer series for reliable, user-friendly and flexible analysis
- 4 models tailored to meet individual needs
- Optimal combination of instrument, software and accessories for a wide range of applications
- Unique and performance enhancing accessories to maximize productivity

Optical system

Spectrometer type	<ul style="list-style-type: none"> ▪ Monochromator with imaging grating and aspheric quartz coated optics ▪ Internal holmium oxide filter
Detector	<ul style="list-style-type: none"> ▪ Two photo diode detectors ▪ Cooled by Peltier element for SPECORD 210/250 PLUS
Sample Position	<ul style="list-style-type: none"> ▪ Designated sample position for turbid samples ▪ Wide range of accessories for optimized solid, liquid and gas sample positioning
Light source	<ul style="list-style-type: none"> ▪ Combination of halogen and deuterium lamp ▪ Lamp change can be set to occur between 300 and 450 nm

Models

SPECORD PLUS Series	SPECORD 50 PLUS	SPECORD 200 PLUS	SPECORD 210 PLUS	SPECORD 250 PLUS
Optical Design	Double beam spectrophotometer with Split Beam Technology	Double beam spectrophotometer with fixed spectral bandwidth	Double beam spectrophotometer with variable spectral bandwidth	Double beam spectrophotometer with variable spectral bandwidth and double monochromator
Sample compartment dimensions (W x H x D)	364 x 200 x 185 mm			
Instrument dimensions (W x H x D)	590 x 290 x 690 mm			
Instrument weight	21 kg	22 kg	22kg	23 kg

Technical Data
SPECORD PLUS Series

Technical Specifications

All data can be checked within the scope of the validation of the instruments.

SPECORD PLUS Series	SPECORD 50 PLUS	SPECORD 200 PLUS	SPECORD 210 PLUS	SPECORD 250 PLUS
Mode	Energy, Absorption, Transmission, Reflectance			
Wavelength range	190–1100 nm	190–1100 nm	185–1200 nm	190–1100 nm
Photometric display range of the software in absorbance	-9 ... 9			
Photometric measuring range in absorbance	-3 ... 3			
Spectral bandwidth	1.4 nm	1.4 nm	variable 0.2/0.5/1/2/4 nm	variable 0.2/0.5/1/2/4 nm
Spectral resolution capability Toluene/Hexane at 20-25 °C	1.6-1.8	1.6-1.8	2.3–2.5	2.3–2.5
Wavelength accuracy (Deuterium line at 656.1 nm)	±0.1 nm			
Wavelength accuracy (at 360.9 nm with holmium oxide filter) *	±0.5 nm			
Wavelength reproducibility (at 360.9 nm with holmium oxide filter, RMS) *	≤0.02 nm			
Zero point of transmission	±0.05 % T (200-1000 nm; Slit 1.4 nm)	±0.05 % T (200-1000 nm; Slit 1.4 nm)	±0.05 % T (190-1150 nm; Slit 2 nm)	±0.05 % T (200-1000 nm; Slit 2 nm)
Photometric accuracy VIS in absorbance (at 546 nm with neutral glass filter Hellma® F4) *	±0.003			
Photometric accuracy UV in absorbance (potassium dichromate) *	±0.01			
Photometric reproducibility in absorbance (at 546 nm with neutral glass filter Hellma® F4, RMS) *	≤0.0005			
Stray light				
198 nm (KCl) **:	≤0.3 % T	≤0.3 % T	≤0.3 % T	≤0.03 % T
220 nm (NaI):	≤0.03 % T	≤0.03 % T	≤0.03 % T	≤0.005 % T
240 nm (NaI):	≤0.03 % T	≤0.03 % T	≤0.03 % T	≤0.005 % T
340 nm (NaNO ₂):	≤0.02 % T	≤0.02 % T	≤0.01 % T	≤0.005 % T

Technical Data

SPECORD PLUS Series

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Baseline noise at 500 nm in absorbance (RMS)	≤0.0001			
Baseline deviation in absorbance	±0.0005 (200–1000 nm; Slit 1.4 nm)	±0.0005 (200–1000 nm; Slit 1.4 nm)	±0.0005 (190–1150 nm; Slit 2 nm)	±0.0005 (200–1000 nm; Slit 2 nm)
Long-term stability at 500 nm in absorbance	±0.0005 1/h			
Registration speed	Up to 12000 nm/min			
Minimum integration time	0.001 s			
Minimum data interval	0.02 nm			

* taking into account the tolerances of the applied standards

** Merck® 1.08164.0001

Additional Technical Data

SPECORD PLUS Series	SPECORD 50 PLUS	SPECORD 200 PLUS	SPECORD 210 PLUS	SPECORD 250 PLUS
Instrument operation	15 ... 35 °C, Rel. Humidity max 90 % at 30 °C			
Instrument electrical requirements	85–264 V/AC 50–60 Hz			
Technical Standards	<ul style="list-style-type: none"> ▪ Tested and designed to be compliant with the legal requirements for laboratory instrumentation and developed and produced in compliance with ISO 9001 ▪ SPECORD PLUS series instruments are certified to comply with the requirements of the EMC standards and bear the CE Mark 			

Control and Data Evaluation

Software	<ul style="list-style-type: none"> ▪ ASpect UV ▪ 21 CFR Part 11 Software Module (optional) ▪ Validation Software Modules – USP, Eur. Ph. and Analytik Jena specifications (optional)
Computer Requirements	<ul style="list-style-type: none"> ▪ Operating system: PC – Windows 7, or higher ▪ PC: Desktop PC, Tower or Laptop; min Intel Pentium 4, 1 GB RAM, 20 GB HDD; CD ROM; USB 2.0; VGA 16-bit, 1024 x 768, 17" Color monitor; Windows-compatible printer

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